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# ***Image Sensing Technologies: Materials, Devices, Systems, and Applications IX***

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# Contents

v *Conference Committee*

---

## SESSION 1    **ADVANCED PHOTODETECTOR TECHNOLOGY I**

---

- 12091 02    **Mid-wavelength and long-wavelength infrared focal planes for smallsat applications (Invited Paper)** [12091-1]
- 12091 03    **Planar strained layer superlattice infrared photodetector using ion implantation** [12091-4]
- 12091 04    **Infrared APD detectors for high bandwidth applications (Invited Paper)** [12091-5]

---

## SESSION 2    **ADVANCED PHOTODETECTOR TECHNOLOGY II**

---

- 12091 05    **Radiation testing of 2.4 micron wavelength extended InGaAs photodiodes for galactic cosmic rays (Invited Paper)** [12091-6]
- 12091 06    **Improved UV to IR band detector performance through advanced nanostructured antireflection coatings** [12091-9]

---

## SESSION 3    **ADVANCED PHOTODETECTOR TECHNOLOGY III**

---

- 12091 07    **Multipolarized nanoantenna-based infrared pixel** [12091-11]
- 12091 08    **Development of high-performance graphene-HgCdTe detector technology for mid-wave infrared applications** [12091-12]

---

## SESSION 4    **IMAGE SENSING APPLICATIONS**

---

- 12091 09    **Atmospheric turbulence characterization using a neuromorphic camera** [12091-15]
- 12091 0A    **Overview of the state of the art in the digitization of drivable forestry roads** [12091-16]
- 12091 0B    **The future trends of EO/IR systems for ISR platforms** [12091-17]
- 12091 0C    **THz response based hardware security and reliability testing powered by deep learning image classification (Invited Paper)** [12091-33]

**POSTER SESSION**

---

- 12091 0D **IR absorption spectra for pesticides using density functional theory** [12091-20]
- 12091 0E **Estimation and sensitivity of dielectric response functions for NIR-SWIR absorbing dyes using Kramers-Kronig analysis** [12091-21]
- 12091 0F **Investigation on surface inspection using polarizing image sensors** [12091-923]
- 12091 0G **Optical image inspection of helical surface geometry of drill** [12091-24]
- 12091 0H **Prediction of the nature of cracking and the paths of crack propagation in nanolayer surface systems based on the method of calculating percolation by nodes and bonds and the scheme of branching processes** [12091-25]
- 12091 0I **Residual compressive stresses as a barrier to crack propagation and a way to increase resistance to brittle fracture in nanostructured systems** [12091-26]
- 12091 0J **Low SWaP-C hyperspectral metamaterial spectrometer (MMS) for narrow-band, wide angle-of-incidence MWIR atmospheric sensing** [12091-34]